

STS12NF30L

N-channel 30V - 0.008Ω - 12A SO-8 STripFET™ II Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	۱ _D
STS12NF30L	30V	<0.009Ω	12A

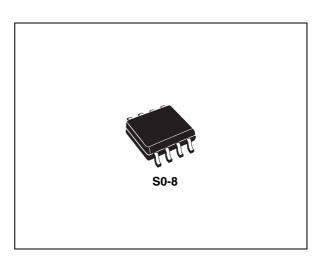
- Standard outline for easy automated surface mount assembly
- Low threshold drive

Description

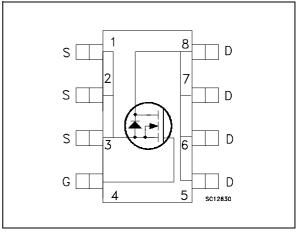
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STS12NF30L	S12NF30L	SO-8	Tape & reel

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1 Electrical ratings

Table 1.	Absolute	maximum	ratings
	Abounde	maximum	radingo

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (v _{gs} = 0)	30	V
V _{GS}	Gate- source voltage	±16	V
I _D	Drain current (continuos) at $T_C = 25^{\circ}C$	12	Α
۱ _D	Drain current (continuos) at $T_C = 100^{\circ}C$	7.5	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	48	Α
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	2.5	W

1. Pulse width limited by safe operating area

Table Z. Thermal data	Table	2.	Thermal	data
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R _{thj-a}	Thermal resistance junction-ambient Max	50	°C/W
TJ	Maximum operating junction temperature	150	°C
T _{stg}	Storage temperature	-55 to 150	°C



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5.	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown voltage	I _D = 250 μA, V _{GS} = 0	30			V
	Zero gate voltage	V _{DS} = Max rating			1	μA
IDSS	Drain current (V _{GS} = 0)	V_{DS} =Max rating, T_{C} =125°C			10	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on	$V_{GS} = 10V, I_{D} = 6A$		0.008	0.009	Ω
ייט (on)	resistance	$V_{GS} = 4.5 V$, $I_{D} = 6 A$		0.01	0.011	Ω

Table 3. On/off states

Table 4. Dynamic

	2 y name					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V _, I _D =6A		15		S
C _{iss}	Input capacitance			2400		pF
C _{oss}	Output capacitance	$V_{DS} = 25V$, f = 1 MHz, V_{GS}		590		pF
C _{rss}	Reverse transfer capacitance	= 0		200		pF
Qg	Total gate charge	V _{DD} = 24V, I _D = 12A,		35	50	nC
Q _{gs}	Gate-source charge	$V_{DD} = 24V, I_D = 12A,$ $V_{GS} = 4.5V$		9		nC
Q _{gd}	Gate-drain charge	(see Figure 13)		18		nC

1. Pulsed: Pulse duration = $300 \ \mu$ s, duty cycle 1.5.

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	V_{DD} =15 V, I _D =6A, R _G =4.7 Ω , V _{GS} = 4.5V (see Figure 12)		35 90		ns ns
t _{d(off)} t _f	Turn-off-delay time Fall time	$V_{DD} = 15V, I_D = 6A,$ $R_G = 4.7\Omega, V_{GS} =$ 4.5V (see Figure 12)		80 35		ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time fall time cross-over time	V_{DD} =24V, I _D =12A, R _G =4.7 Ω , V _{GS} =4.5V (see Figure 14)		35 35 80		ns ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current				40	Α
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				160	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 12A, V_{GS} = 0$			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 12A, V_{DD} = 15V$ di/dt = 100A/µs, $T_j = 150^{\circ}C$ (see Figure 14)		114 456 8		ns nC A

Table 6. Source drain diode

1. Pulse width limited by safe operating area.

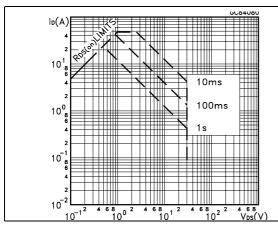
2. Pulsed: Pulse duration = 300 $\mu s,$ duty cycle 1.5%



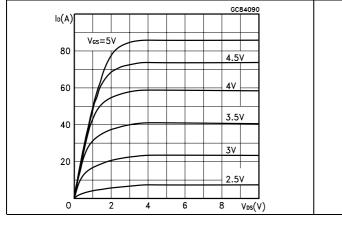
 $\frac{GC83240}{Z_{\text{th}} = k R_{\text{th}J-c}}$ $\delta = t_{p}/\tau$

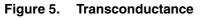
2.1 Electrical characteristics (curves)

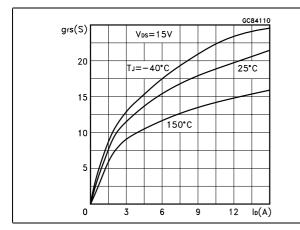
Figure 1. Safe operating area

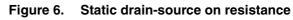


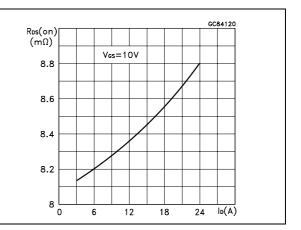




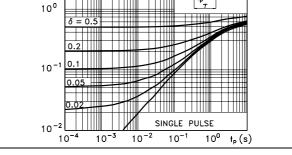








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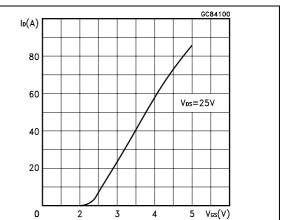


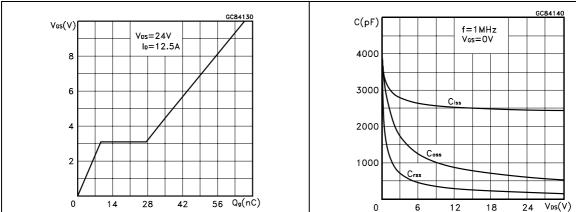
Thermal impedance

Figure 4. Transfer characteristics

Figure 2.

Κ





Gate charge vs. gate-source voltage Figure 8. Capacitance variations Figure 7.

Figure 9. Normalized gate threshold voltage vs. temperature

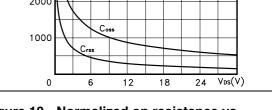


Figure 10. Normalized on resistance vs. temperature

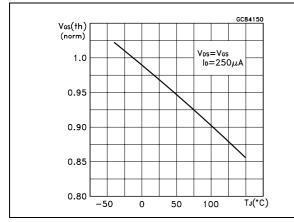
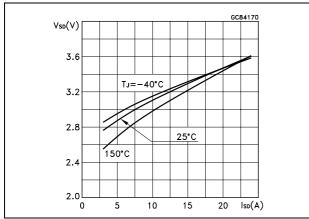
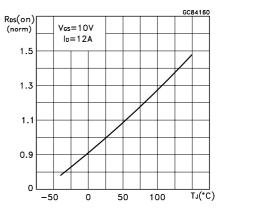


Figure 11. Source-drain diode forward characteristics

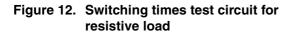






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3 Test circuit



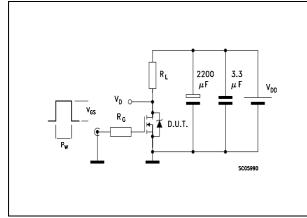
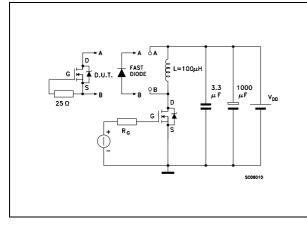
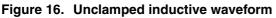
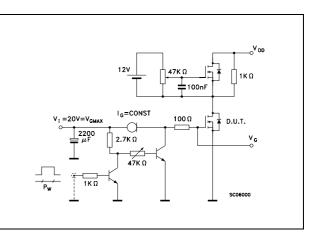
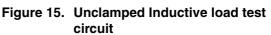


Figure 14. Test circuit for inductive load switching and diode recovery times









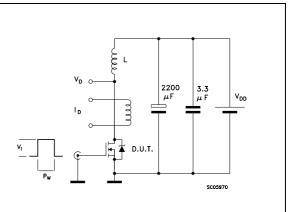


Figure 17. Switching time waveform

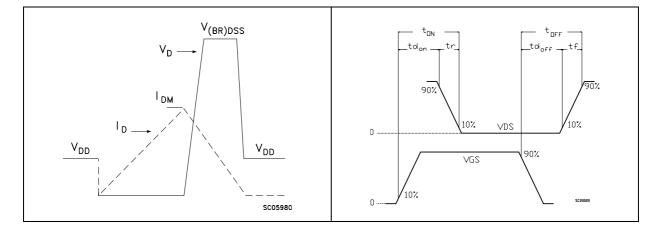


Figure 13. Gate charge test circuit

4 Package mechanical data

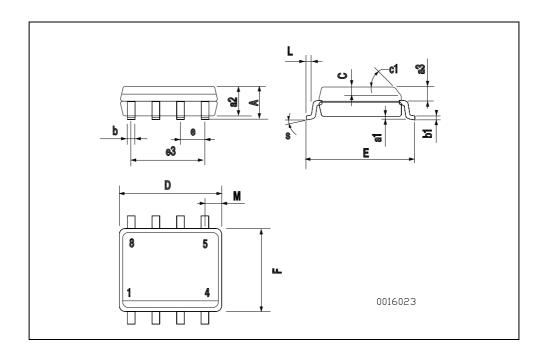
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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023





5 Revision history

Date	Revision	Changes
09-Sep-2004	6	Complete version
17-Aug-2006	7	New template, no content change
31-Jan-2007	8	Typo mistake on Table 1.



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